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DESIGN, SOLUTION SYNTHESIS, CHARACTERIZATION AND PHOTOLUMINESCENCE AS WELL AS AFTERGLOW STUDIES OF Y₂O₃:Eu³⁺, Ho³⁺ PHOSPHORS

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ABSTRACT

 $Y_2O_3:Eu^{3+}$, Ho^{3+} phosphors were prepared by a complex based precursor solution method using Triethanolamine (TEA) as complexing agent. X-ray diffraction (XRD) patterns indicate that Eu^{3+} and Ho^{3+} doping do not show obvious effect to the cubic Y_2O_3 crystal. Under UV 254 nm excitation, $Y_2O_3:Eu^{3+}$, Ho^{3+} phosphor shows a red-emitting long afterglow phenomenon, and the Eu^{3+} ion are the luminescent center during the decay process. The decay characteristic of $Y_2O_3:Eu^{3+}$, Ho^{3+} phosphor is according with the double exponential equation. The traps in the $Y_2O_3:Eu^{3+}$, Ho^{3+} host is originated from Eu^{3+} ion. The co-doped Ho^{3+} ion shoaled the trap depth, which is beneficial for the carriers to escape from the trap resulting into the afterglow phenomenon.

Keywords: Y₂O₃:Eu³⁺, Ho³⁺, Photoluminescence, Doping, Rare earth ions.

1. INTRODUCTION

Long afterglow phosphor is a kind of eco-friendly material, which could adsorb energy from the sunlight, fluorescent lamp or UV light, and store the absorbed energy, and then release the energy gradually in form of afterglow ^[1–13]. Because of the long afterglow properties, these materials have been used in many fields, such as illumination in darkness, emergency sign, artwork, luminescent paints, detection of radiation, display, and photocatalytic degradation ^[6–9]. Among the afterglow phosphors $SrAl_2O_4:Eu^{2+}$, Dy^{3+} and $CaA_{12}O_4:Eu^{2+}$, Nd^{3+} ^[1, 10–13]. However, the duration and intensity of long afterglow phosphor are inferior in comparison with the former two phosphors $^{[5, 14-16]}$. Therefore, the development of novel, high-intensity, long-duration, afterglow phosphor is required. Recently, Xu and co-workers reported a new NIR long-persistent $SrGa_{12}O_{19}:Cr^{3+}$ phosphor with the emission duration of more than 2 h with a broadband phosphorescence from 650 to 950 nm ^[17]. Duan et al. synthesized a novel long lasting phosphorescence phosphor $La_2Zr_2O_7:Sm^{3+}$, Ti^{4+} , and the color of afterglow/photoluminescence

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can be adjusted ^[18]. Besides the novel host, Y_2O_3 is a conventional host for rare-earth doping ^[19]. For example, Y_2O_3 :Eu³⁺ was widely used as the phosphor in color display. In this chapter, a redemitting long afterglow material Y_2O_3 :Eu³⁺, Ho³⁺ was synthesized and structure, photoluminescence and decay characteristics of the material were investigated, and the potential mechanism of the afterglow phenomenon was discussed.

2. EXPERIMENTAL SECTION

2.1 Synthesis of Phosphor:

In our preparative method Y_2O_3 (Sigma-Aldrich), Eu₂O₃ (Sigma-Aldrich) and Ho₂O₃ (Sigma-Aldrich) were dissolved in minimum volume of concentrated HNO₃ and boiled on water bath to get clear solutions of $Y(NO_3)_3$, Eu(NO₃)₃ and Ho(NO₃)₃. The nitrate solutions were taken in a beaker according to the required stoichiometry. After that, TEA (triethanolamine) was added to that nitrate solution and the molecular ratio of metal salt: TEA was maintained 1:4. Then certain amount of concentrated HNO₃ solution was added to maintain the pH 3–4 to avoid any kind of metal hydroxide precipitation. TEA was used as it is an efficient chelating ligand and possesses good coordination properties with the metal ions. The clear solution of TEA complexed metal nitrate is evaporated on a hot plate at 180 °C with constant stirring. Continuous heating of the solution causes foaming and puffing. During evaporation of the precursor solution, the TEA present in the system probably led to the formation of vinyl functional groups that cause polymerization. The black fluffy has been calcined and then annealed at 600 °C to get the required phosphor.

2.2 Characterization:

The phase purity of the as-synthesized sample was identified by using powder X-ray diffraction (XRD) analysis with a Bruker AXS D8 advanced automatic diffractometer with Cu-Ka radiation ($\lambda = 1.5418$ Å), over the angular range $10^{\circ} \le 2\theta \le 80^{\circ}$, operating at 40 kV and 40 mA. The photoluminescence (PL) excitation and emission spectra as well as afterglow of the sample were analyzed by using a RF-5301PC (Shimadzu, Japan) equipped with a 150 W Xenon light source and the slit width was kept 1.5 nm.

3. RESULT AND DISCUSSION

An X-ray diffraction pattern for the sample is shown in Fig. 1. The observed values of the diffraction pattern match quite well with the standard JNCPDS file (88-1040) and the patterns exhibit cubic symmetry [space group Ia-3 (206)] of Y_2O_3 without any impurity which indicates that doping of Eu³⁺ and Ho³⁺ in Y_2O_3 lattice creates a solid solution.

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Fig. 1: XRD of Y₂O₃ doped with Eu³⁺ and Ho³⁺ phosphor

Fig. 2 shows the photoluminescence spectra of the phosphors excited by UV light at the wavelength of 254 nm. $Y_2O_3:Eu^{3+}$, Ho^{3+} phosphors exhibited the strong red emission. Sharp emissions peaking at 582, 588, 594, 600 and 612 nm can be assigned to the ${}^5D_0 \rightarrow {}^7F_J$ (where J is 0, 1 and 2) transitions of Eu^{3+} ion (marked in Fig 2). No other emission can be observed in the $Y_2O_3:Eu^{2+}$, Ho^{3+} sample, indicating that the doped Ho^{3+} ion do not show any significant emission under 254 nm excitation. The strongest red emission at 612 nm is due to the low symmetry position of Eu^{3+} ion with an inversion center and this forced-electric dipole transition is often dominant in the emission spectrum. So the strongest emission at 612 nm is ascribed to Eu^{3+} ion which occupied on the C₂ site and these ions are dominant in the host. Moreover, $Y_2O_3:Eu^{3+}$, Ho^{3+} samples were excited under UV 254 nm for 5 min, and then the excitation source was removed to examine whether the materials show long afterglow emission in the dark. $Y_2O_3:Eu^{2+}$, Ho^{3+} sample exhibits an obvious red afterglow lasting for about 5 min, as can be seen in the left inset of Fig 3, the persistent luminescence of $Y_2O_3:Eu^{2+}$, Ho^{3+} material can be observed by the naked eyes and it can last for 5 min.

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The lifetime curve of the Y_2O_3 :Eu³⁺, Ho³⁺ sample was recorded and shown in Fig. 3. It contains a rapid-decaying process and a slow-decaying process, the decay curve is similar to that of typical long afterglow materials. The decay characteristic of Y_2O_3 :Eu³⁺, Ho³⁺ phosphor is similar to the rare-earth doping alkaline-earth aluminates long afterglow materials, which have drawn much attention from 1990s. One of the typical aluminates is SrAl₂O₄:Eu²⁺, RE³⁺ (RE = Dy, Nd and Ho, etc.), which was successfully synthesized by Matsuzawa in 1996^[21]. Generally, the Eu²⁺ ion is the only luminescent center in SrAl₂O₄:Eu²⁺, RE³⁺ phosphors, and the doped RE³⁺ ions often generate the trap level in the host ^[10, 20]. In order to exhibit long afterglow phenomena, the phosphor should have suitable trap level and trap density and the trapped carriers do recombine in the luminescent centers occurred with the afterglow.

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Fig. 3: The decay curve of the Y₂O₃:Eu³⁺, Ho³⁺ sample, the left inset is the afterglow photograph of Y₂O₃:Eu³⁺, Ho³⁺ phosphor which was examined at 2 min after the UV 254 nm light excitation for 5 min.

4. CONCLUSION

 Y_2O_3 doped with Eu^{3+} and Ho^{3+} phosphor was synthesized by a complex based precursor solution method. The phase identification by XRD shows the formation of pure cubic phase of Y_2O_3 . $Y_2O_3:Eu^{3+}$, Ho^{3+} phosphor exhibits a red long afterglow phenomenon. The traps in the $Y_2O_3:Eu^{3+}$, Ho^{3+} were generated by the addition of Eu^{3+} ions. The doped of Ho^{3+} shoaled the trap depth, which is beneficial for the carriers to escape from the trap as a result of which the afterglow appears sequentially.

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